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L1	1	THOMAS-JASON-B.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:42
L2	0	BILDNER-MARK-J.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:42
L3	0	THOMAS-BRANDY-M.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:43
L4	1	YOUNG-CHRISTOPHER-D.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:43
L5	13	MOORE-RICHARD-P.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:44
L6	0	BIRO-ROSS-A.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:44
L7	0	PEMBERTON-ALISSA-S.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:45
L8	0	PERLMAN-DIANE-B.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 19:45

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L1	81092	((("709"/(203,223-224,217-219).ccls.) or ("707"/("1,3,5,10").ccls.))) and @ad<"20000523"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 14:18
L2	331	(benchmark\$1! with (entity or entities or company or companies or organization\$1! or corporation\$1! or business\$2! or entrepreneur\$1!))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 14:32
L3	31	1 and 2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 15:30
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L9	0	8 and @ad<"2000523"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 15:42
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L12	4	(scor\$3 or rat\$3) same analyz\$3 same (web adj (page\$1! or content or file\$1! or document\$1!)) with ((entities or entity or corporation or business\$2! or organization\$1! or entrepreneur\$1!) )	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 15:54

L13	0	1 and (scor\$3 or rat\$3) same analyz\$3 same (web adj (page\$1! or content or file\$1! or document\$1!)) same ((entities or entity or corporation or business\$2! or organization\$1! or entrepreneur\$1!)) )	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 15:54
L14	21	(scor\$3 or rat\$3) same analyz\$3 same (web adj (page\$1! or content or file\$1! or document\$1!)) same ((entities or entity or corporation or business\$2! or organization\$1! or entrepreneur\$1!)) )	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/20 15:54

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Computer , Volume: 28 , Issue: 8 , Aug. 1995

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